Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/685,732	LIN, FENG	
Examiner	**Art Unit**	
David Mis	2817	

SEARCHED			
Class	Subclass	Date	Examiner
331	34, 57,	4/7/2005	DM
	66, 111,		
	143, 176,		
	177R,		
	185-186		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR